

SIPC26N60S5

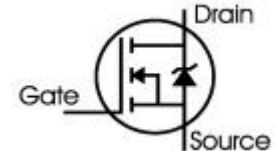
Fast CoolMOS™ Power Transistor

FEATURES:

- New revolutionary high voltage technology
- Ultra low gate charge
- Worldbest $R_{DS(on)}$ per chip area
- Ultra low effective capacitances
- Improved noise immunity

Applications:

- SMPS, resonant applications



Chip Type	V_{DS}	I_D	Die Size	Package	Ordering Code
SIPC26N60S5	600V	20A	5,83 x 4,52 mm ²	sawn on foil	Q67041-S2851

MECHANICAL PARAMETER:

Raster size	5,83 x 4,52	mm
Source pad size	4,1 x 5,2	
Gate pad size	0.38 x 0.44	
Area total / active	26.35 / 21,05	mm ²
Thickness	220	µm
Wafer size	200	mm
Flat position	0	grd
Max.possible chips per wafer	1042	
Passivation frontside	Nitride	
Emitter metallization	5000 nm Al Si 1% CU 0.5%	
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding	
Die bond	electrically conductive glue or solder	
Wire bond (proposed)	Source: Al, ≤ 500µm; Gate: Al, ≤ 125µm	
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm	
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month	

MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Drain-Source voltage	V_{DS}	600	V
DC drain current, limited by T_{jmax}	I_D	20	A
Pulsed drain current, t_p limited by T_{jmax}	I_{Dpuls}	40	A
Gate source voltage	V_{GS}	± 20	V
Operating junction and storage temperature	T_j, T_{stg}	-55 ... +150	$^{\circ}C$
Reverse diode dv/dt $I_S=20A, V_{DS}<V_{DSS}, di/dt=100 A/\mu s, T_{jmax}=150^{\circ}C$	dv/dt	6	KV/ μs

STATIC CHARACTERISTICS (tested on chip), $T_j=25^{\circ}C$, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=0.25mA$			600	V
Gate-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=10A$		0,18	0,23 ¹⁾	Ω
Gate threshold voltage	$V_{GS(th)}$	$I_D=1mA, V_{GS}=V_{DS}$	3.5	4.5	5.5	V
Zero gate voltage drain current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V$		0.1	25	μA
Gate-source leakage current	I_{GSS}	$V_{DS}=0V, V_{GS}=20V$			100	nA

¹⁾ this correlates to a max. $R_{DS(on)}$ -value of 190 m Ω at $V_{GS}=10V, I_D=10A$ of this chip packaged in a TO220-package

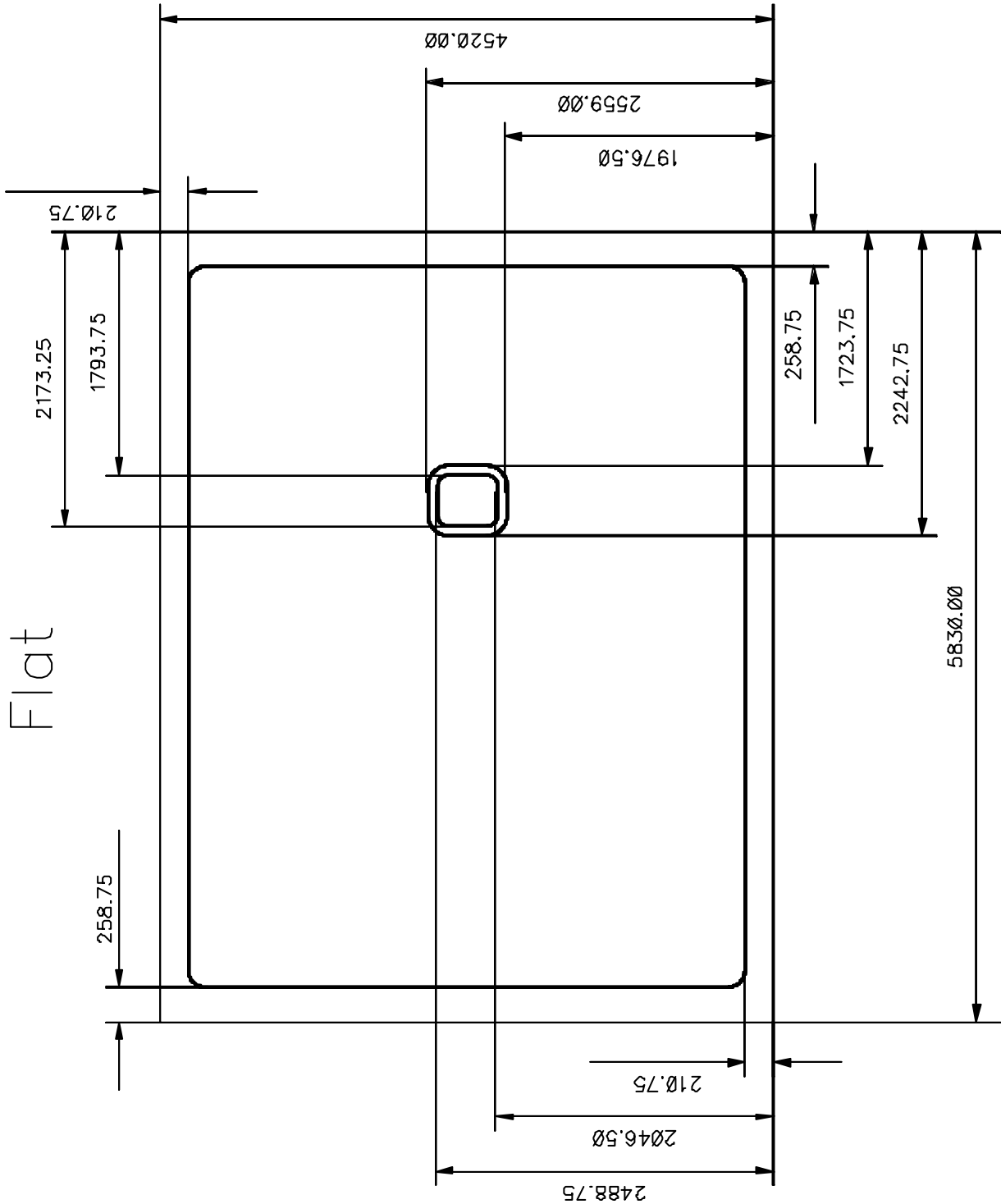
ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Input capacitance	C_{iss}	$V_{DS}=25V,$	-	3000	-	pF
Output capacitance	C_{oss}	$V_{GS}=0V,$	-	1170	-	
Reverse transfer capacitance	C_{riss}	$f=1MHz$	-	28	-	

SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	$T_j=25^{\circ}C$	-	120	-	ns
Rise time	t_r	$V_{DD}=350V,$	-	25	-	
Turn-off delay time	$t_{d(off)}$	$I_D=20 A,$	-	140	-	
Fall time	t_f	$V_{GS}=0 / 10V,$	-	30	-	
		$R_G= 5,7\Omega$				

CHIP DRAWING:





Preliminary

SIPC26N60S5

FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet		
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DESCRIPTION:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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